

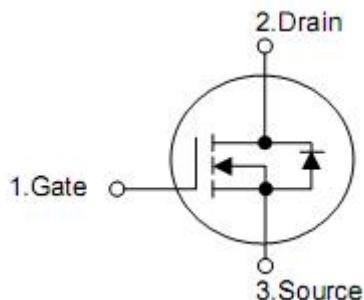
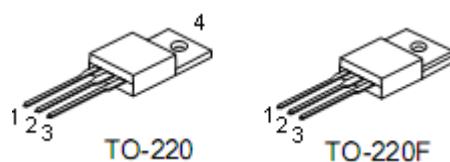
## 1. Description

The KIA8N60 is a high voltage MOSFET and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and have a high rugged avalanche characteristics. This power MOSFET is usually used at high speed switching applications in power supplies, PWM motor controls, high efficient DC to DC converters and bridge circuits.

## 2. Features

- $R_{DS(on)}=0.98\Omega$  @  $V_{GS}=10V$
- Ultra low gate charge (typical 29nC)
- Fast switching capability
- Avalanche energy tested
- Improved dv/dt capability,

## 3. Pin configuration



Pin	Function
1	Gate
2	Drain
3	Source
4	Drain

## 4. Absolute maximum ratings

( $T_c=25^\circ\text{C}$  , unless otherwise specified)

Parameter	Symbol	Rating		Units
		TO220	TO220F	
Drain-source voltage	$V_{DSS}$	600		V
Gate-source voltage	$V_{GSS}$	$\pm 30$		V
Drain current continuous	$I_D$	7.5	7.5*	A
		4.6	4.6*	A
Drain current pulsed (note1)	$I_{DP}$	30	30*	A
Peak diode recovery dv/dt (note3)	dv/dt	4.5		V/ns
Total power dissipation	$P_D$	147	48	W
		1.18	0.38	W/ $^\circ\text{C}$
Junction temperature	$T_J$	+150		$^\circ\text{C}$
Storage temperature	$T_{STG}$	-55~+150		$^\circ\text{C}$

\* Drain current limited by maximum junction temperature

## 5. Thermal data

Parameter	Symbol	Rating		Unit
		TO220	TO220F	
Thermal resistance junction-ambient	$R_{thJA}$	62.5		$^\circ\text{C}/\text{W}$
Thermal resistance, case-to-Sink Typ	$R_{thCS}$	0.5	--	$^\circ\text{C}/\text{W}$
Thermal resistance junction-case	$R_{thJC}$	0.85	2.6	$^\circ\text{C}/\text{W}$

## 6. Electrical characteristics

( $T_J=25^\circ\text{C}$ ,unless otherwise notes)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
Off characteristics						
Drain-source breakdown voltage	$\text{BV}_{\text{DSS}}$	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250\mu\text{A}$	600	-	-	V
Zero gate voltage drain current	$I_{\text{DSS}}$	$V_{\text{DS}}=600\text{V}, V_{\text{GS}}=0\text{V}$	-	-	1	$\mu\text{A}$
		$V_{\text{DS}}=480\text{V}, T_c=125^\circ\text{C}$	-	-	10	$\mu\text{A}$
Gate-body leakage current	$I_{\text{GSS}}$	$V_{\text{GS}}=30\text{V}, V_{\text{DS}}=0\text{V}$	-	-	100	nA
		$V_{\text{GS}}=-30\text{V}, V_{\text{DS}}=0\text{V}$	-	-	-100	nA
Breakdown voltage temperature coefficient	$\Delta \text{BV}_{\text{DSS}}/\Delta T_J$	$I_{\text{D}}=250\mu\text{A}$	-	0.6	-	V/ $^\circ\text{C}$
On characteristics						
Gate threshold voltage	$V_{\text{GS(TH)}}$	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=250\mu\text{A}$	2.0	-	4.0	V
Static drain-source on-resistance	$R_{\text{DS(ON)}}$	$V_{\text{GS}}=10\text{V}, I_{\text{D}}=3.75\text{A}$ (Note 4)	-	0.98	1.2	$\Omega$
Dynamic characteristics						
Input capacitance	$C_{\text{ISS}}$	$V_{\text{DS}}=25\text{V}, V_{\text{GS}}=0\text{V}, f=1\text{MHz}$	-	100	-	pF
Output capacitance	$C_{\text{OSS}}$		-	110	-	pF
Reverse transfer capacitance	$C_{\text{RSS}}$		-	12	-	pF
Switching characteristics						
Turn-on delay time	$t_{\text{D(ON)}}$	$V_{\text{DD}}=300\text{V}, R_{\text{G}}=25\Omega, I_{\text{D}}=7.5\text{A}$ (note4,5)	-	20	-	ns
Rise time	$t_{\text{R}}$		-	50	-	ns
Turn-off delay time	$t_{\text{D(OFF)}}$		-	80	-	ns
Fall time	$t_{\text{F}}$		-	70	-	ns
Total gate charge	$Q_{\text{G}}$	$V_{\text{DS}}=480\text{V}, V_{\text{GS}}=10\text{V}$ $I_{\text{D}}=7.5\text{A}$ (note4,5)	-	29	-	nC
Gate-source charge	$Q_{\text{GS}}$		-	4.7	-	nC
Gate-drain charge	$Q_{\text{GD}}$		-	12.5	-	nC
Drain-source diode characteristics						
Drain-source diode forward voltage	$V_{\text{SD}}$	$V_{\text{GS}}=0\text{V}, I_{\text{SD}}=7.5\text{A}$	-	-	1.4	V
Continuous drain-source current	$I_{\text{SD}}$		-	-	7.5	A
Pulsed drain-source current	$I_{\text{SM}}$		-	-	30	A
Reverse recovery time	$t_{\text{RR}}$	$I_{\text{SD}}=7.5\text{A},$ $di/dt=100\text{A}/\mu\text{s}$ (note4)	-	350	-	ns
Reverse recovery charge	$Q_{\text{RR}}$		-	3.3	-	$\mu\text{C}$

Note: 1.Repetitive Rating: Pulse width limited by maximum junction temperature

2.  $L=7.3\text{mH}, I_{\text{AS}}=7.5\text{A}, V_{\text{DD}}=50\text{V}, R_{\text{G}}=25\Omega$ ,Starting  $T_J=25^\circ\text{C}$

3.  $I_{\text{SD}}\leq 7.5\text{A}, di/dt\leq 200\text{A}/\mu\text{s}, V_{\text{DD}}\leq \text{BV}_{\text{DSS}}$ ,Starting  $T_J=25^\circ\text{C}$

4. Pulse test: pulse width  $\leq 300\mu\text{s}$ , duty cycle  $\leq 2\%$

5. Essentially independent of operating temperature.

## 7. Typical characteristics

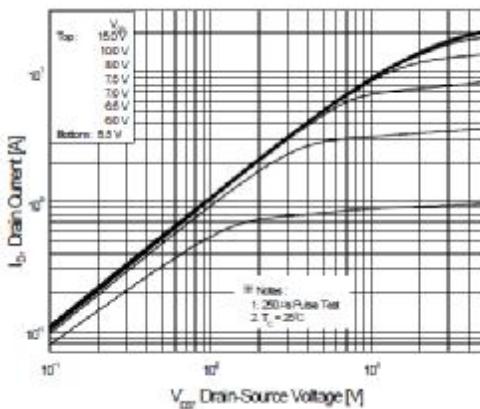


Figure 1. On-Region Characteristics

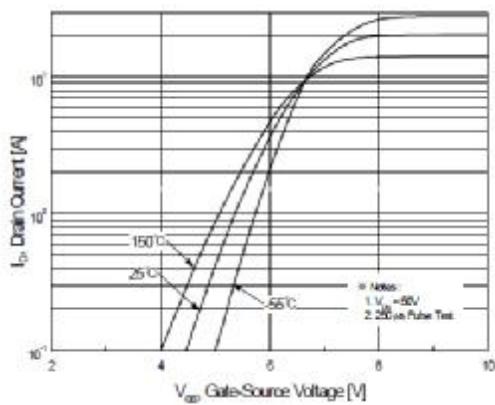


Figure 2. Transfer Characteristics

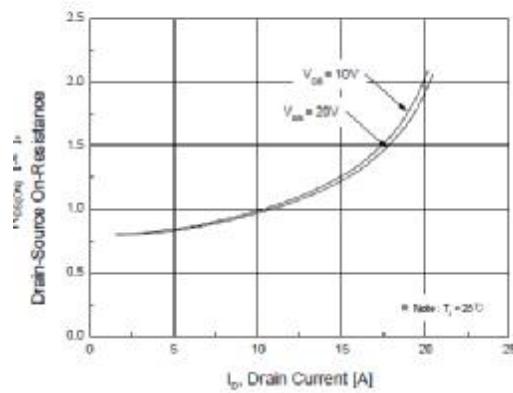


Figure 3. On-Resistance Variation vs.  
Drain Current and Gate Voltage

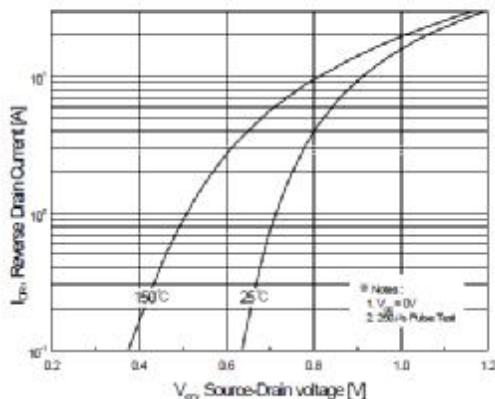


Figure 4. Body Diode Forward Voltage  
Variation vs. Source Current  
and Temperature

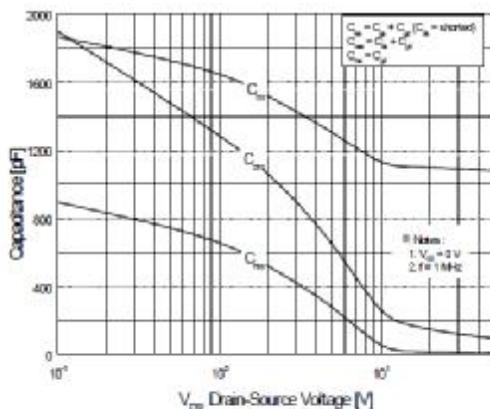


Figure 5. Capacitance Characteristics

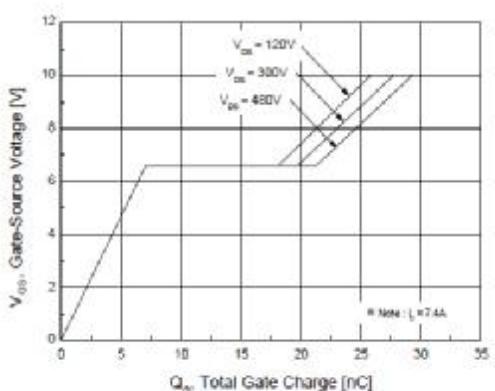
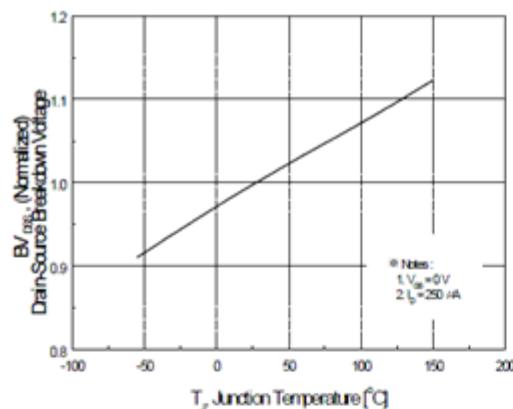
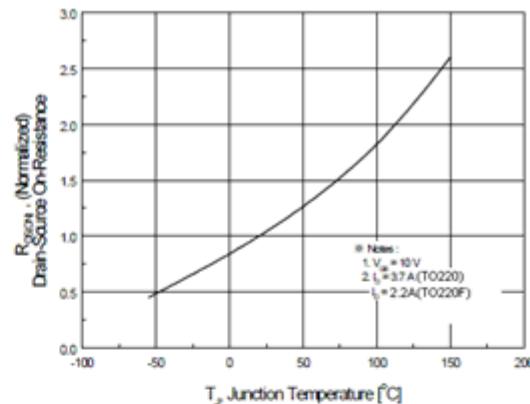


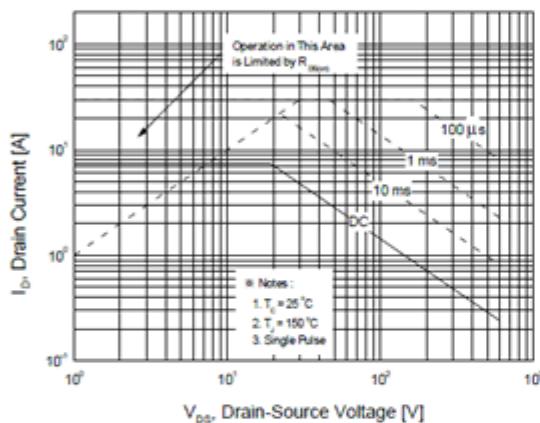
Figure 6. Gate Charge Characteristics



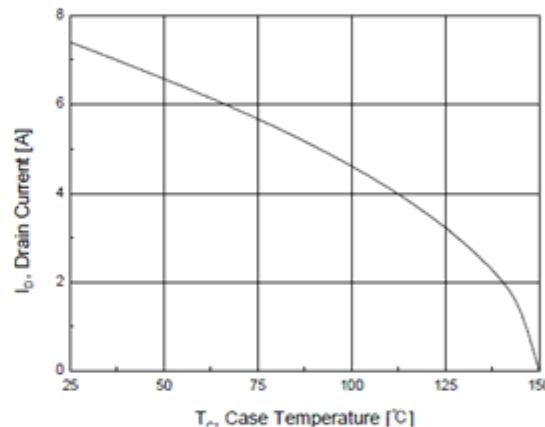
**Figure 7. Breakdown Voltage Variation vs. Temperature**



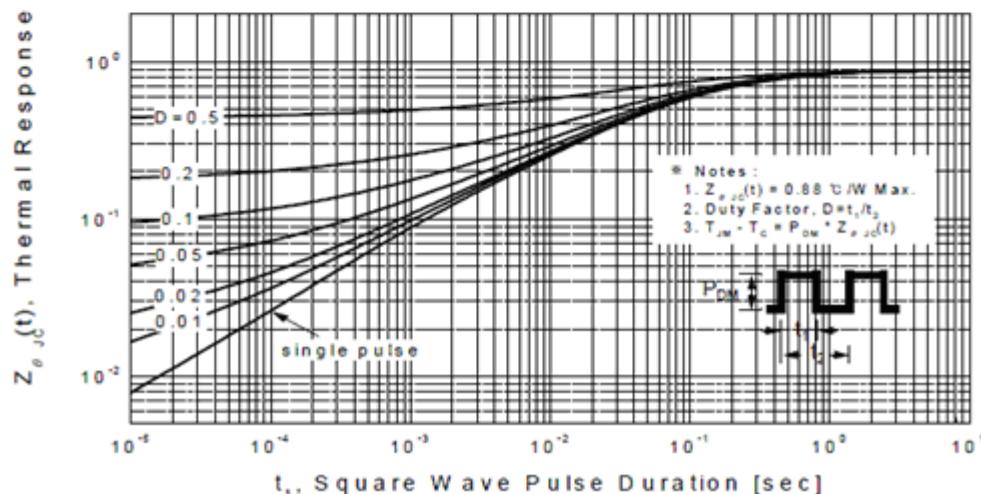
**Figure 8. On-Resistance Variation vs. Temperature.**



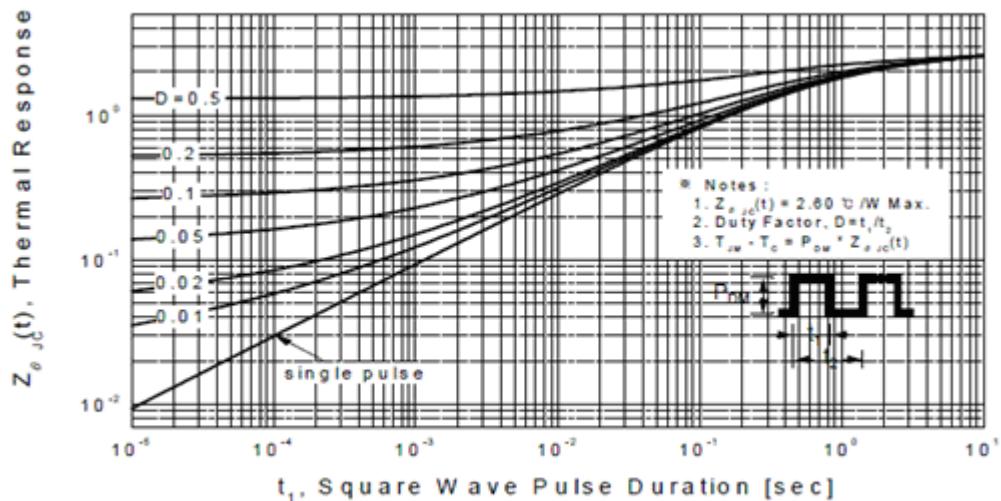
**Figure 9. Maximum Safe Operating Area**



**Figure 10. Maximum Drain Current vs. Case Temperature**



**Figure 11-1. Transient Thermal Response Curve for TO220**



**Figure 11-2. Transient Thermal Response Curve for TO220F**